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Application/Control No.	Applicant(s)/Patent under Reexamination	
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	SEARCHED				
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INTERFERENCE SEARCHED				
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
STIC- sequence search of SEQ ID NO:1 standard nucleic acid database Sequence search of SEQ ID NO:2 standard protein databse	1/12/2006	K
West search for inventor's names	1/18/2006	96
STN search for inventor's names	1/18/2006	38
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